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Information Disclosure Statement By Applicant	Applicant: Christopher M. Warnock, et al.	
(Use Several Sheets if Necessary)	Filing Date: November 28, 2003	Group: 2624

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	1	EP 0881591	12/2/1998	Stolin				
	2	EP 0881592	12/2/1998	Taylor				
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Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.